



Test Report

No. : CE/2007/63198B Date : 2008/04/28 Page : 1 of 3

COMCHIP TECHNOLOGY CO., LTD.

NO. 31, YNGHSIN LANE, YINGTAU RD, YINGGE TOWN, TAIPEI COUNTY,
TAIWAN



The following sample(s) was/were submitted and identified by/on behalf of the client as :

Sample Description	:	SMD DIODES
Style/Item No.	:	CDXXC SERIES
Sample Receiving Date	:	2007/06/14
Testing Period	:	2007/06/14 TO 2007/06/23

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Test Result(s)	:	Please refer to next page(s).
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Shin-Jyh Chen

Shin-jyh Chen / Asst. Manager
Signed for and on behalf of
SGS TAIWAN LTD.
Chemical Laboratory - Taipei

Test Report

No. : CE/2007/63198B Date : 2008/04/28 Page : 2 of 3

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Test Result(s)

PART NAME NO.1 : SMD DIODES

Test Item (s):	Unit	Method	MDL	Result
				No.1
Halogen	---	With reference to prEN14582 method B. Analysis was performed by IC method for F, Cl, Br, I content.	---	---
Halogen-Chlorine (Cl) (CAS No.: 007782-50-5)	mg/kg	With reference to prEN14582 method B. Analysis was performed by IC method for Chlorine content.	50	n.d.
Halogen-Fluorine (F) (CAS No.: 007782-41-4)	mg/kg	With reference to prEN14582 method B. Analysis was performed by IC method for Fluorine content.	50	n.d.
Halogen-Bromine (Br) (CAS No.: 007726-95-6)	mg/kg	With reference to prEN14582 method B. Analysis was performed by IC method for Bromine content.	50	n.d.
Halogen-Iodine (I) (CAS No.: 007553-56-2)	mg/kg	With reference to prEN14582 method B. Analysis was performed by IC method for Iodine content.	50	n.d.

- Note :
1. mg/kg = ppm
 2. n.d. = Not Detected
 3. MDL = Method Detection Limit
 4. "---" = Not Conducted

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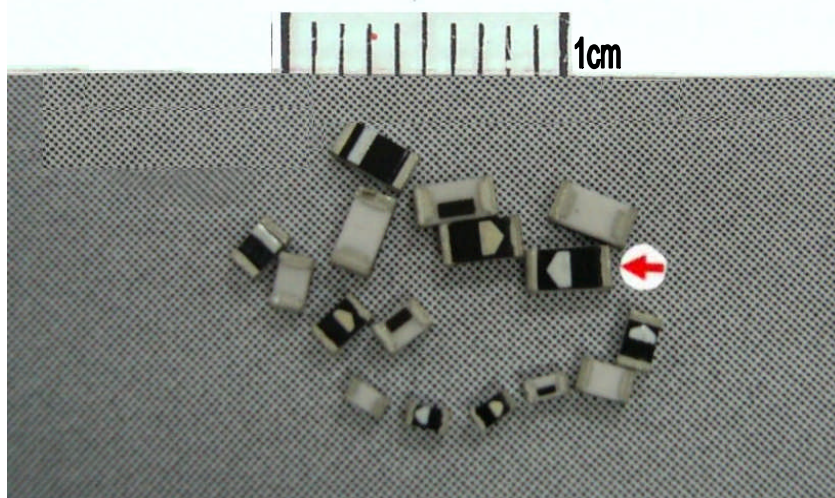
Page : 3 of 3

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** End of Report **